Spare Cavities for TRISTAN 508 MHz SC Cavities

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<u>Abstract</u>

Four 508 MHz 5-cell niobium SC cavities were manufactured as spare cavities for TRISTAN SC cavities. In the final vertical measurements, average Q_0 at low field and maximum accelerating field ($E_{acc,max}$) were 3.3×10^9 and 13.1 MV/m, respectively. One cavity, 18b, marked the highest $E_{acc,max}$ of 15.1 MV/m. In the horizontal tests, however, one of the cavities, 17b, showed a serious degradation and had to be re-treated. Moreover, another cavity, 17a, suffered an accidental mechanical kink during its disassembly. Nevertheless both of them recovered to show a good performance after repair. The details are presented in this paper.

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<u>1.Introduction</u>

Thirty-two superconducting (SC) accelerating cavities were manufactured and have been operated in the TRISTAN main ring [1,2]. Only a few cavities degraded and did not recover by warming up [3]. To replace the degraded cavities, we started manufacturing four spare cavities in 1989. The procedure for the fabrication was the same as those produced previously [4]. The technology and technique to obtain 10 MV/m-level cavities have been matured for 500 MHz 5-cell cavities, but the problem that the performance turns out to be deteriorated in the horizontal tests by about 30 % on average remains to be solved [1].

2. Summary of vertical measurements

The results of the final vertical measurements are summarized in Table 1. Unloaded Q is plotted against E_{acc} in Fig. 1. The inverse of unloaded Q, which is proportional to the total loss on the cavity surface, is plotted against the square of surface peak electric field, E_{sp}^2 in Fig. 2. Non-linear part of this curve indicates electron loading. As one can see in this figure, 18a showed the strongest electron loading due to field emission. Field enhancement factor, β , also showed the highest value as shown in Table 1.

3. Fabrication and surface treatments

Results of fabrication and pre-tuning are summarized in Table 2. In Table 3, processes of final surface treatments, what we call EP II, are shown with their goals and consumed time. In Table 4, conditions of final surface treatments of spare cavities are summarized.

4. Repair of 17a and 17b

One cavity, 17b, was found to be degraded in the horizontal measurement. Its $E_{acc,max}$ was only 3 MV/m. Since there are two 5-cell cavities in one horizontal cryostat, 17a, the other cavity in the same cryostat, also had to be disassembled to retreat 17b. An accident took place when these cavities were being disassembled.

When 17a was suspended with two Nylon ropes and crane, it kinked suddenly as shown in Fig. 6(a) probably because of too much torque concentrated on the iris between the two ropes.

Repair processes of 17a and 17b are summarized as follows,

17a (Accidental inelastic deformation, Fig.6(a)

- 1) Restore the shape of the cavity using the fixtures used for pretuning.
- 2) Anneal for stress release.
- 3) Pre-tuning for field flatness and to restore the resonant frequency.
- 4) Standard final surface treatment (Table 4, EP 10 μ m).

<u>17b (Degraded after horizontal assembly)</u>

- 1) Vertical measurement and temperature mapping (Figs. 4 and 5).
- 2) Inspection of inner surface and sanding off the defects found (e.g., Fig. 6(b)).
- 3) EP of 10 μ m and rinse (1st and 2nd rinse in Table 3).
- 4) Inspection of inner surface.
- 5) Standard final surface treatments (Table 4, EP 10 μ m).

For 17b, temperature mapping with Allen-Bradley carbon resistors was performed on the first 2 cells from HOM-side because these cells were suspected to be the cause of the degradation from the side-bands measurements in the 2nd vertical measurement [5]. The results of the mapping are shown in Fig. 5. They showed heated spots around the iris between the two cells. Figure 6(b) shows one of the defects found on the iris during the inspection.

 Q_0-E_{acc} curve of 17a after the repair process is shown in Fig. 3 along with the curve before this accident. The changes of Q_0 -

 E_{acc} curves of 17b after different processes are also shown in Fig. 4. Finally in both cases, repair processes were successful and E_{acc} reached well above 10 MV/m.

5. Horizontal measurements

After connecting two 5-cell cavities in a horizontal position and adding 4 HOM couplers and extension beam pipes in a clean environment, we install these cavities in a horizontal cryostat [1]. After this so-called horizontal assembly, these cavities are cooled down with LHe and tested in the radiation shield blocks by the assembly area. The results of the horizontal tests are summarized in Table 5. As one can see, $E_{acc,max}$ became lower than that of vertical measurements, although the exact maximum values were not reached because we did not raise the input power in fear of serious damage due to discharges.

6. Vacuum and Eacc.max

In Fig. 7, pressures inside the cavity before pre-cooling with liquid N₂ and during the vertical measurements are shown for all the TRISTAN cavities and spare cavities as a function of $E_{acc,max}$. As one can see, it seems that a pressure on the order of 10^{-10} Torr during the measurements is necessary to obtain the gradient higher than 12 MV/m.

7. Conclusion

The technology to obtain 500 MHz 5-cell cavities which have accelerating fields of higher than 10 MV/m has been matured. The highest $E_{acc,max}$ was 15 MV/m so far. We have, however, some problems associated with the degradation after the horizontal assembly. We have not clarified the reason for this degradation. What we have to do in the future will be to solve this problem and to investigate on the limitation of the accelerating fields so that we can get higher gradient and stable cavities.

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<u>References</u>

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Cavity #	17a	17b	18a	186
Meas. date	28 June 91	12 June 91	30 Jan. 91	7 Feb. 91
f ₀ (MHz)	508.240	508.178	508.204	508.218
Q _{15D} ¹⁾ (×10 ¹¹)	3.33	2.57	2.49	3.03
Q ₀ at low field (×10 ⁹)	2.8	3.6	3.3	3.4
E _{acc,max} (MV/m)	13.5	12.8	11.1	15.1
Limitation	Saturation of amplifier	Saturation of amplifier	Breakdown	Capacity of He ret. line
γ	17.6	17.5	18.4	15.8
β (Δ1/Q)	-	-	279	78,606 ²⁾
β (elec.)	-	-	520	-
β (X-ray)	483 ³⁾	302	750	385
Vacuum dur. Meas.	6.7	2.5	6.8	2.6

Table 1. Results of final vertical measurements ofsparecavities.

1) Q_{ext} of monitor port.

2) This value was different according to the range of E_{acc} .

3) This value is inaccurate due to the big scatter of the data in F-N plot.

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18b	148-182	Defocus	80 µm	700°C×1.5H	in Ti box	$1.8-3.1 \times 10^{-5}$			508.296		94		508.132		66		4.62	
18a	187-209	Defocus	80 µm	700°C×1.5H	in Ti box	$1.8-3.1 \times 10^{-5}$			508.289		93		508.123		66		4.48	
17b	165-198	Defocus	80 µm	700°C×1.5H	in Ti box	$2.5-4.5 \times 10^{-5}$			508.205		93		508.119		66		4.52	
17a	140-193	Defocus	80 µm	700°C×1.5H	in Ti box	$2.1-3.9 \times 10^{-5}$			507.906		8 1		508.13		66		5.73	
Cavity #	RRR	EBW	EP I	Anneal		Vacuum	at 700°C (Torr)	Pre-tuning	f ₀ at 4.2 K ¹⁾ bef.	tuning (MHz)	Field flatness bef.	tuning (%)	f ₀ at 4.2 K ¹⁾ aft.	tuning (MHz)	Field flatness aft.	tuning (%)	Contraction by	evacuation (mm)

Table 2. Results of fabrication.

1) Calculated from measured frequency [6].

Table 3.KEK standard final surface treatments
for Nb 500 MHz 5-cell SC cavities. (1/2)

Process	Method	Goal	Time (min.)
Electropolish	H_2SO_4 :HF=85:10 Circulation of EP solution Rotation ¹⁾ of	Removal of inner surface by 10 μm	26
	cavity (1 rpm) Overflow with		
lst rinse	demineralized water in a vertical position	pH of outlet water ≥ 3	27-30
Disassembly	Cables, fixtures and extraction of cathode bag	No dirt on cathode bag and joints	35-40
2nd rinse	Shower with demineralized water	pH of outlet water ≥ 5	30
H_2O_2 rinse	10 w% H ₂ O ₂ Rotation (3 rpm) with H ₂ O ₂ filled	No indicator Removal of carbon and	20×2 (Rev. rotation)
	horizontal Immersed vertically in a warm (50-55 °C) ultrasonic bath	formation of stable Nb ₂ O ₅ layer are expected.	40
Rinse	Shower with demineralized water after dumping_H ₂ O ₂	Rinse off H ₂ O ₂	10

(Continued)

Table 3.KEK standard final surface treatments
for Nb 500 MHz 5-cell SC cavities. (2/2)

Process	Method	Goal	Time (min.)
3rd rinse	Immersed in a warm (50-55 °C)	Specific resistivity of	10-15
	ultrasonic bath Overflow with deminaralized water		160-1902)
4th rinse	Overflow with	No indicator	5
	ultra-pure water in the same way as above in a warm US bath Rotation (3 rpm) on the bed	Removal of particles smaller than 10 µm, bacteria and TOC ³⁾ is expected	5×2 (Rev. rotation)
	Overflow with ultra-pure water		5
Final rinse	Shower with ultra-pure water	Removal of residues is expected	1
Seal & package	Sealed with filtered N_2 gas	Prevention of airborne contamination is expected	35-40

1) All rotations are performed in a horizontal position about cavity axis.

2) This depends on how long it takes to attain the goal.

3) Total Organic Carbon .

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Table 4.	Conditions	of final	surface	treatments	of
	spare cav	ities.			

Cav. No.	17a	17b	18a	186
EP depth	10µm	10µm	10µm	10µm
Set cav. Temp (°C)	31.8	31.4	31.7	31.3
Reservoir Temp. (°C)	27.6	26.7	27.6	27.5
Voltage (V)	24.0	25.6	25.0	25.7
Average Current (A)	967.5	952.0	938.9	931.0
Av. Current density (mA/cm ²)	53.3	52.4	51.7	51.3
pH aft. 1st water rinse	3.00	2.80	3.14	2.8
pH aft. 2nd water rinse	4.90	4.70	4.82	4.77
Res. of 3rd rinse water (Mohm.cm)	7.0	6.9	6.8	6.9
Res. of 4th rinse water (Mohm.cm)	7.9	6.9	8.7	8.6

Other common parameters are

Total electropolishing area: 18150.0 cm², H₂O₂ rinsing time : 80 min, Cavity rotation during EP : 1.0 rpm, Flow rate of EP solution : 60 liters/min.

Cavity #	17a	17b	18a	18b
Q _L (×10 ⁶)	0.822	0.721	.768	0.905
(band wid.)				
Q _L (×10 ⁶)	0.899	0.747	0.863	1.005
(200W decay)				
Q _L (×10 ⁶)	0.830	0.784	0.766	1.003
$(E_{acc}=5MV/m)$				
Q _{15D} ¹⁾ (×10 ¹¹)	3.10	2.71	2.53	2.82
$E_{acc,max}(MV/m)$	6.822)	>7.00	>6.16	>7.00
Q ₀ (×10 ⁹)	2.29	2.57	1.38	2.63
(6 MV/m)				
β (electron)	no electron	433	886	451
	(-6.5	(6.0-7.0	(4.8-5.5	(6.0-7.0
	MV/m)	MV/m)	MV/m)	MV/m)
∆f/load(Hz/kg)	552.2	558.0	563.2	533.8
Spring constant	158.9	148.9	130.1	151.8
(kg/mm)				
∆f/length	87.7	83.1	73.3	81.0
(kHz/mm)				
Piezo storoke	≅7.4	≅7.4	≅7.2	≡7.3
(kHz)				
f ₀ at load free	508.307	508.276	508.286	508.328
(MHz)				
HOM filter a	508.53	508.53	≅508.75	508.62
(MHz)				
HOM filter b	508.58	508.46	508.57	508.65
(MHz)	:			
Tatal loss at 6	84.8	78.5	126.1	81.1
MV/m (W)				
Static loss of	27	27	31	31
cryostat (W)				

Table 5.Results of horizontal measurements.

- 1) Q_{ext} of a monitor port below input coupler.
- 2) Coupler arc discharge.



Fig. 1. Q-E curves of four cavities obtained from final vertical measurements.



Fig. 2. $1/Q_0$ vs E_{sp}^2 at the final vertical measurements.



Fig. 3. Vertical measurements of 17a. 2nd measurement was performed after repairing the accidental kink of the cavity.



Fig. 4. Vertical measurements of 17b. 2nd measurement was done after its degradation was found at the horizontal measurement and the 3rd was performed after sanding off the defects and re-EP.

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Fig. 5. Temperature mapping at the 2nd vertical measurement of 17b.



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Pressure (Torr)



Fig. 7. Vacuum of all 5-cell SC cavities before precooling with LN_2 and during the vertical measurements as a function of $E_{acc,max}$.